



FCC TEST REPORT

FCC ID: SLGUXXXX

Product : USB Flash Drive

Trade Name : N/A

U1XXX, U2XXX, U3XXX, U4XXX, U5XXX

Model Number : U6XXX, U7XXX, U8XXX, U9XXX (remark: first
X=0-9 second X=0-9 third X=A-F)

Prepared for

Apexto Electronics Company Limited

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Prepared by

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TEST RESULT CERTIFICATION

Applicant's name : Apexto Electronics Company Limited
Address : 2-3/F,Block 6, xiawei yuan Industry Park, xiawei yuan New Village, Gushu Area, Bao'an District, Shenzhen, China
Manufacturer's Name : Apexto Electronics Company Limited
Address : 2-3/F,Block 6, xiawei yuan Industry Park, xiawei yuan New Village, Gushu Area, Bao'an District, Shenzhen, China

Product description

Product name : USB Flash Drive
U1XXX, U2XXX, U3XXX, U4XXX, U5XXX U6XXX,
Model and/or type reference : U7XXX, U8XXX, U9XXX (remark: first X=0-9 second X=0-9
third X=A-F)
FCC Part15B:2012

Standards : ANSI C63.4:2009

This device described above has been tested by NTEK, and the test results show that the equipment under test (EUT) is in compliance with Part 15 of FCC Rules. And it is applicable only to the tested sample identified in the report.

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Date of Test :

Date (s) of performance of tests : 05 Mar. 2013 ~12 Mar. 2013

Date of Issue : 13 Mar. 2013

Test Result : **Pass**

Testing Engineer : Apple Huang
(Apple Huang)

Technical Manager : Jim He
(Jim He)

Authorized Signatory : Bovey Yang
(Bovey Yang)

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1. TEST SUMMARY

Test procedures according to the technical standards:

EMC Emission				
Standard	Test Item	Limit	Judgment	Remark
FCC Part15B:2012 ANSI C63.4: 2009	Conducted Emission	Class B	PASS	
	Radiated Emission	Class B	PASS	

NOTE:

- (1) 'N/A' denotes test is not applicable in this Test Report
- (2) For client's request and manual description, the test will not be executed.

1.1 TEST FACILITY

NTEK Testing Technology Co., Ltd

Add. : 1/F, Building E, Fenda Science Park, Sanwei Community, Xixiang Street, Bao'an District, Shenzhen P.R. China.

FCC Registration Number:238937; IC Registration Number:9270A-1

CNAS Registration Number:L5516

1.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement $y \pm U$, where expended uncertainty U is based on a standard uncertainty multiplied by a coverage factor of $k=2$, providing a level of confidence of approximately **95 %**.

A. Conducted Measurement :

Test Site	Method	Measurement Frequency Range	U , (dB)	NOTE
NTEKC01	ANSI	150 KHz ~ 30MHz	3.2	

B. Radiated Measurement :

Test Site	Method	Measurement Frequency Range	U , (dB)	NOTE
NTEKA01	ANSI	30MHz ~ 1000MHz	4.7	
		1GHz ~6GHz	5.0	

2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF EUT

Equipment	USB Flash Drive				
Model Name	U100A				
Serial No	U1XXX, U2XXX, U3XXX, U4XXX, U5XXX U6XXX, U7XXX, U8XXX, U9XXX (remark: first X=0-9 second X=0-9 third X=A-F)				
Model Difference	All the model are the same circuit and module, except the model name.				
Product Description	<p>The EUT is a USB Flash Drive.</p> <table border="1"><tr><td>Operating frequency:</td><td>N/A</td></tr><tr><td>Connecting I/O port:</td><td>USB</td></tr></table> <p>Based on the application, features, or specification exhibited in User's Manual, the EUT is considered as an ITE/Computing Device. More details of EUT technical specification, please refer to the User's Manual.</p>	Operating frequency:	N/A	Connecting I/O port:	USB
Operating frequency:	N/A				
Connecting I/O port:	USB				
Power Source	DC Voltage				
Power Rating	DC 5V from PC 120V/60Hz				

2.2 DESCRIPTION OF TEST MODES

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	data transmission

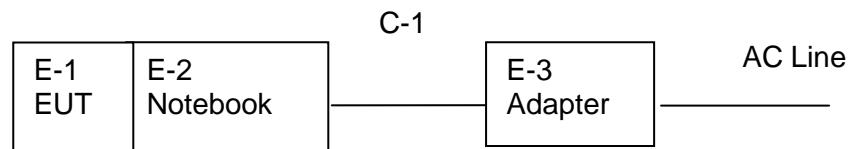
For Conducted Test	
Final Test Mode	Description
Mode 1	data transmission

For Radiated Test	
Final Test Mode	Description
Mode 1	data transmission

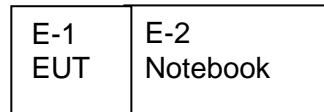
2.3 DESCRIPTION OF TEST SETUP

Mode 1:

CE:



RE:



2.4 DESCRIPTION TEST PERIPHERAL AND EUT PERIPHERAL

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Note:

- (1) The support equipment was authorized by Declaration of Confirmation.
- (2) For detachable type I/O cable should be specified the length in cm in 『Length』 column.
- (3) "YES" means "shielded" "with core"; "NO" means "unshielded" "without core".

2.5 MEASUREMENT INSTRUMENTS LIST

2.5.1 CONDUCTED TEST SITE

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	LISN	R&S	ENV216	101313	Jul. 06, 2013
2	LISN	EMCO	3816/2	00042990	Jul. 06, 2013
3	50Ω Switch	ANRITSU CORP	MP59B	6200983704	Jul. 06, 2013
4	Test Cable	N/A	C01	N/A	Jul. 06, 2013
5	Test Cable	N/A	C02	N/A	Jul. 06, 2013
6	Test Cable	N/A	C03	N/A	Jul. 06, 2013
7	EMI Test Receiver	R&S	ESCI	101160	Jul. 06, 2013
8	Passive Voltage Probe	ESH2-Z3	R&S	100196	Jul. 06, 2013
9	Triple-Loop Antenna	EVERFINE	LIA-2	11020003	Jul. 06, 2013
10	Absorbing Clamp	R&S	MDS-21	100423	Jul. 08, 2013

2.5.2 RADIATED TEST SITE

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Bilog Antenna	TESEQ	CBL6111D	31216	Jul. 06, 2013
2	Test Cable	N/A	R-01	N/A	Jul. 06, 2013
3	Test Cable	N/A	R-02	N/A	Jul. 06, 2013
4	EMI Test Receiver	R&S	ESCI-7	101318	Jul. 06, 2013
5	Antenna Mast	EM	SC100_1	N/A	N/A
6	Turn Table	EM	SC100	060531	N/A
7	50Ω Switch	Anritsu Corp	MP59B	6200983705	Jul. 06, 2013
8	Spectrum Analyzer	Agilent	E4407B	MY45108040	Jul. 06. 2013
9	Horn Antenna	EM	EM-AH-10180	2011071402	Jul. 06. 2013
10	Amplifier	EM	EM-30180	060538	Jul. 06. 2013

3. EMC EMISSION TEST

3.1 CONDUCTED EMISSION MEASUREMENT

3.1.1 POWER LINE CONDUCTED EMISSION (Frequency Range 150KHz-30MHz)

FREQUENCY (MHz)	Class A (dBuV)		Class B (dBuV)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 -0.5	79.00	66.00	66 - 56 *	56 - 46 *
0.50 -5.0	73.00	60.00	56.00	46.00
5.0 -30.0	73.00	60.00	60.00	50.00

Note:

- (1) The tighter limit applies at the band edges.
- (2) The limit of " * " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.

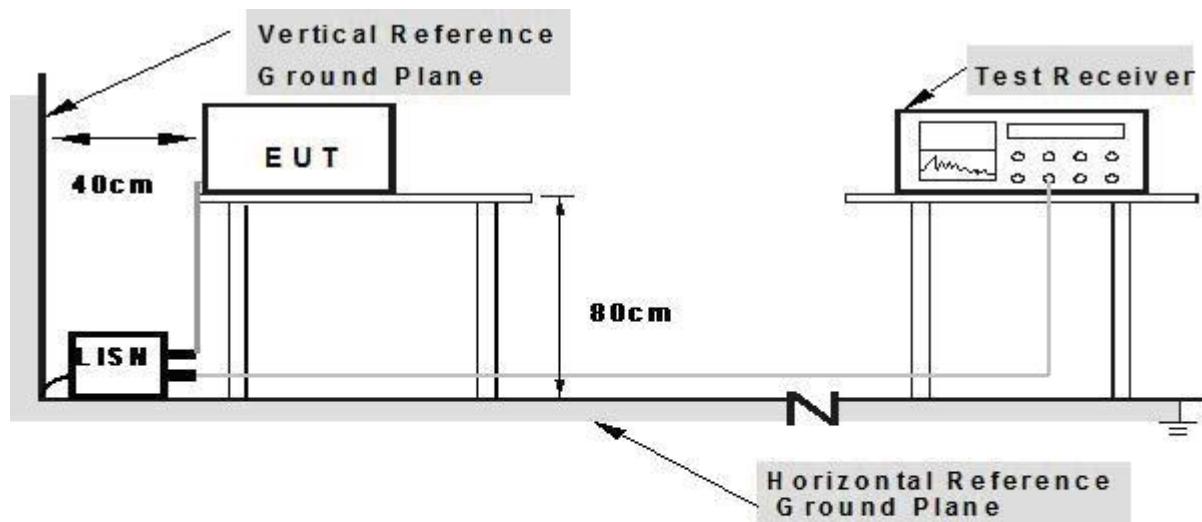
The following table is the setting of the receiver

Receiver Parameters	Setting
Attenuation	10 dB
Start Frequency	0.15 MHz
Stop Frequency	30 MHz
IF Bandwidth	9 kHz

3.1.2 TEST PROCEDURE

- a. The EUT was placed 0.4 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d. LISN at least 80 cm from nearest part of EUT chassis.
- e. For the actual test configuration, please refer to the related Item –EUT Test Photos.

3.1.3 TEST SETUP



Note: 1. Support units were connected to second LISN.

2. Both of LISNs (A and B) are 80 cm from EUT and at least 80 cm from other units and other metal planes

3.1.4 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.3 Unless otherwise a special operating condition is specified in the follows during the testing.

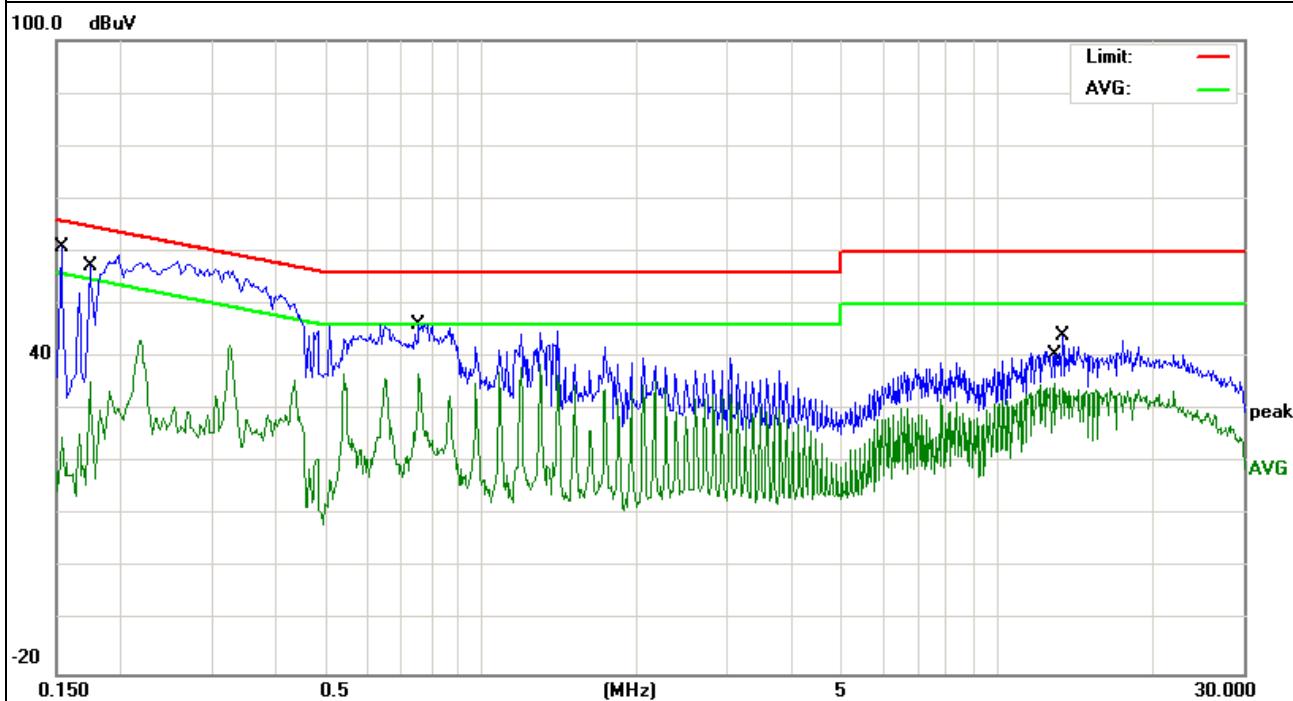
3.1.5 TEST RESULTS

EUT :	USB Flash Drive	Model Name. :	U100A
Temperature :	26 °C	Relative Humidity :	54%
Pressure :	1010hPa	Test Date :	2013-03-10
Test Mode :	Data transmission	Phase :	L
Test Voltage :	DC 5V from PC 120V/60Hz		

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Detector Type
(MHz)	(dB μ V)	(dB)	(dB μ V)	(dB μ V)	(dB)	
0.1539	50.86	9.85	60.71	65.78	-5.07	QP
0.174	25.3	10	35.3	54.76	-19.46	AVG
0.758	36.01	10.23	46.24	56	-9.76	QP
0.758	26.74	10.23	36.97	46	-9.03	AVG
12.9098	24.66	10.51	35.17	50	-14.83	AVG
13.3419	33.51	10.51	44.02	60	-15.98	QP

Remark:

1. All readings are Quasi-Peak and Average values.
2. Factor = Insertion Loss + Cable Loss.

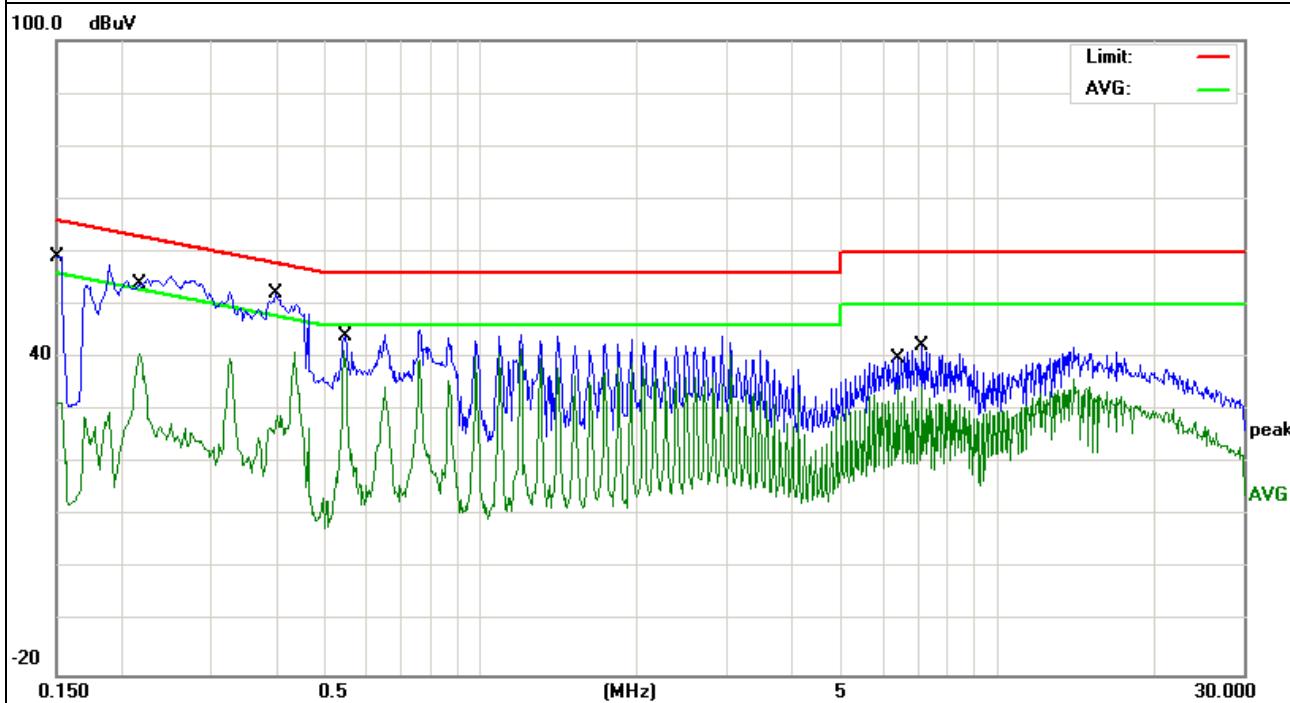


EUT :	USB Flash Drive	Model Name. :	U100A
Temperature :	26 °C	Relative Humidity :	54%
Pressure :	1010hPa	Test Date :	2013-03-10
Test Mode :	Data transmission	Phase :	N
Test Voltage :	DC 5V from PC 120V/60Hz		

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Detector Type
(MHz)	(dB μ V)	(dB)	(dB μ V)	(dB μ V)	(dB)	
0.150	49.32	9.82	59.14	66	-6.86	QP
0.218	31.04	9.8	40.84	52.89	-12.05	AVG
0.398	42.11	10.05	52.16	57.89	-5.73	QP
0.542	31.09	10.2	41.29	46	-4.71	AVG
6.4019	24.57	10.41	34.98	50	-15.02	AVG
7.1659	31.95	10.42	42.37	60	-17.63	QP

Remark:

1. All readings are Quasi-Peak and Average values.
2. Factor = Insertion Loss + Cable Loss.



3.2 RADIATED EMISSION MEASUREMENT

3.2.1 LIMITS OF RADIATED EMISSION MEASUREMENT

FREQUENCY (MHz)	Class A (at 10m)	Class B (at 3m)
	dBuV/m	dBuV/m
30 ~ 88	39.0	40.0
88 ~ 216	43.5	43.5
216 ~ 960	46.5	46.0
Above 960	49.5	54.0

Notes:

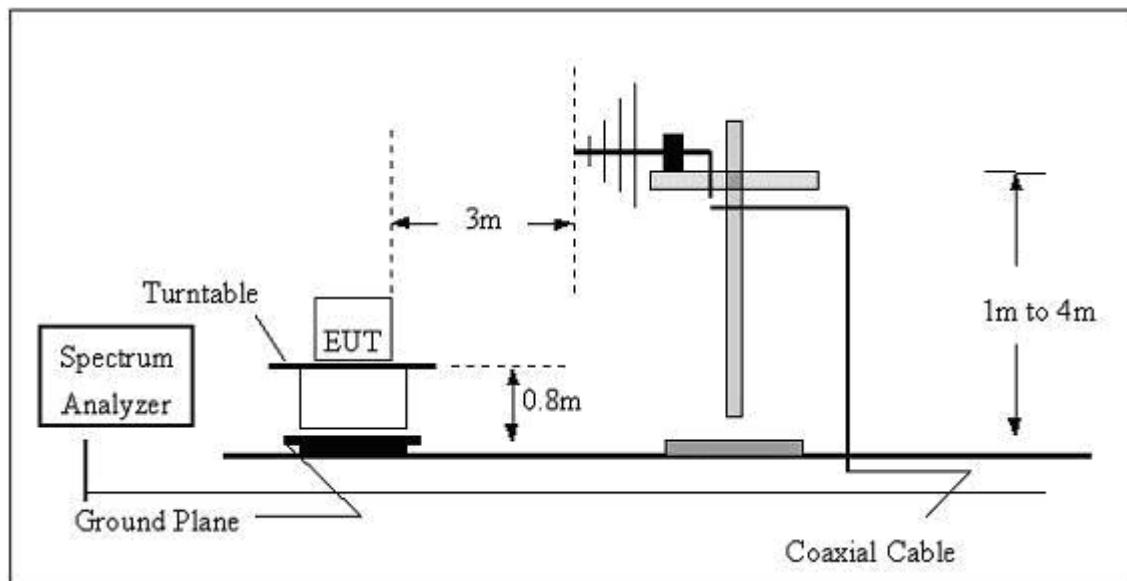
- (1) The limit for radiated test was performed according to as following:
FCC PART 15B /ICES-003.
- (2) The tighter limit applies at the band edges.
- (3) Emission level (dBuV/m)=20log Emission level (uV/m).

3.2.2 TEST PROCEDURE

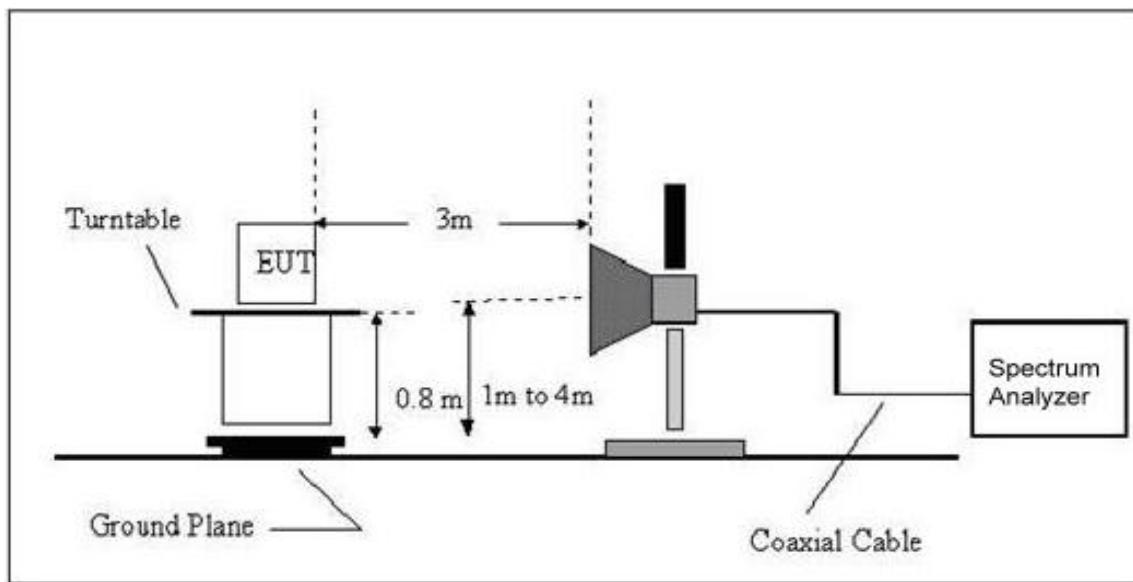
- a. The measuring distance of at 10 m shall be used for measurements at frequency up to 1GHz. For frequencies above 1GHz, any suitable measuring distance may be used.
- b. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 10 meter open area test site. The table was rotated 360 degrees to determine the position of the highest radiation.
- c. The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. The initial step in collecting conducted emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured, above 1G Average detector mode will be instead.
- e. If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP(AV) Limits and then no additional QP Mode measurement performed.
- f. For the actual test configuration, please refer to the related Item –EUT Test Photos.

3.2.3 TEST SETUP

(A) Radiated Emission Test Set-Up Frequency Below 1 GHz



(B) Radiated Emission Test Set-Up Frequency Above 1GHz



3.2.4 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.3 Unless otherwise a special operating condition is specified in the follows during the testing.

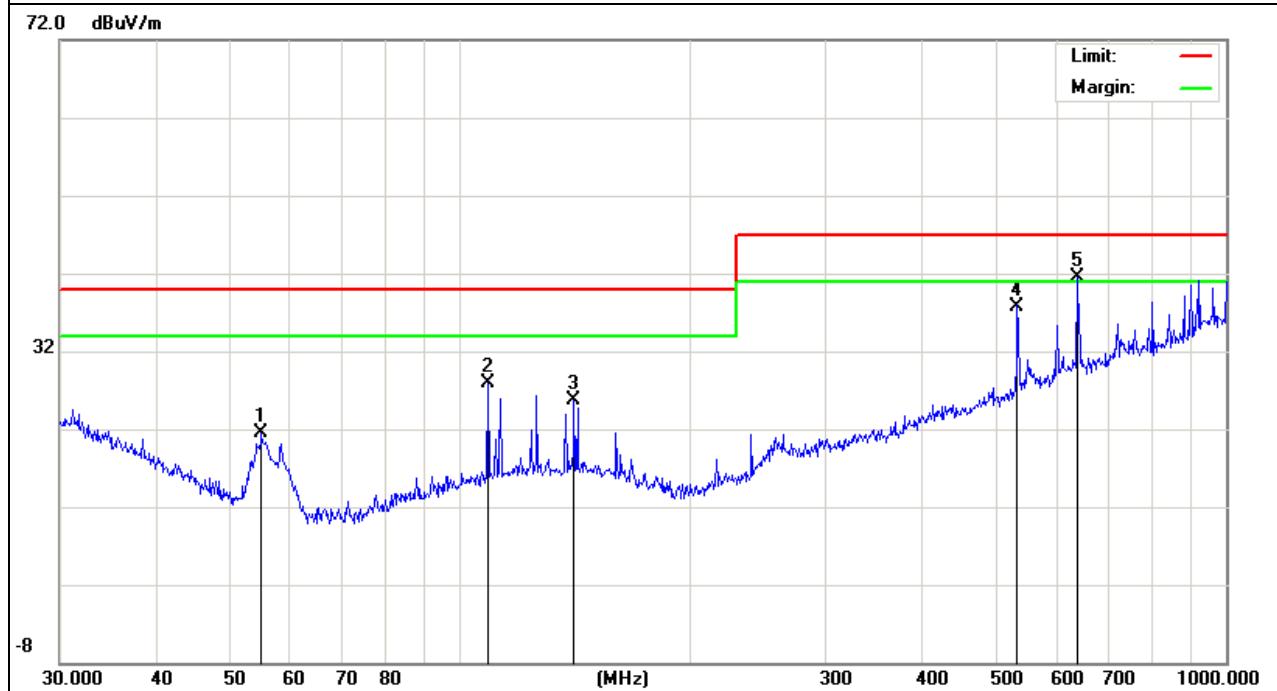
3.2.5 TEST RESULTS

EUT :	USB Flash Drive	Model Name :	U100A
Temperature :	24 °C	Relative Humidity :	54%
Pressure :	1010 hPa	Test Date :	2013-03-11
Test Mode :	Data transmission	Polarization :	Horizontal
Test Power :	DC 5V from PC 120V/60Hz		

Frequency (MHz)	Meter Reading (dB μ V)	Factor (dB)	Emission Level (dB μ V/m)	Limits		Margin (dB)	Detector Type
				(dB μ V/m)	(dB)		
55.0274	15.23	6.27	21.5	40	-18.5	QP	
108.647	16.35	11.47	27.82	40	-12.18	QP	
140.8351	13.53	12.14	25.67	40	-14.33	QP	
533.832	16.22	21.58	37.8	47	-9.2	QP	
638.3686	18.01	23.47	41.48	47	-5.52	QP	

Remark:

1. Factor = Antenna Factor + Cable Loss – Pre-amplifier.

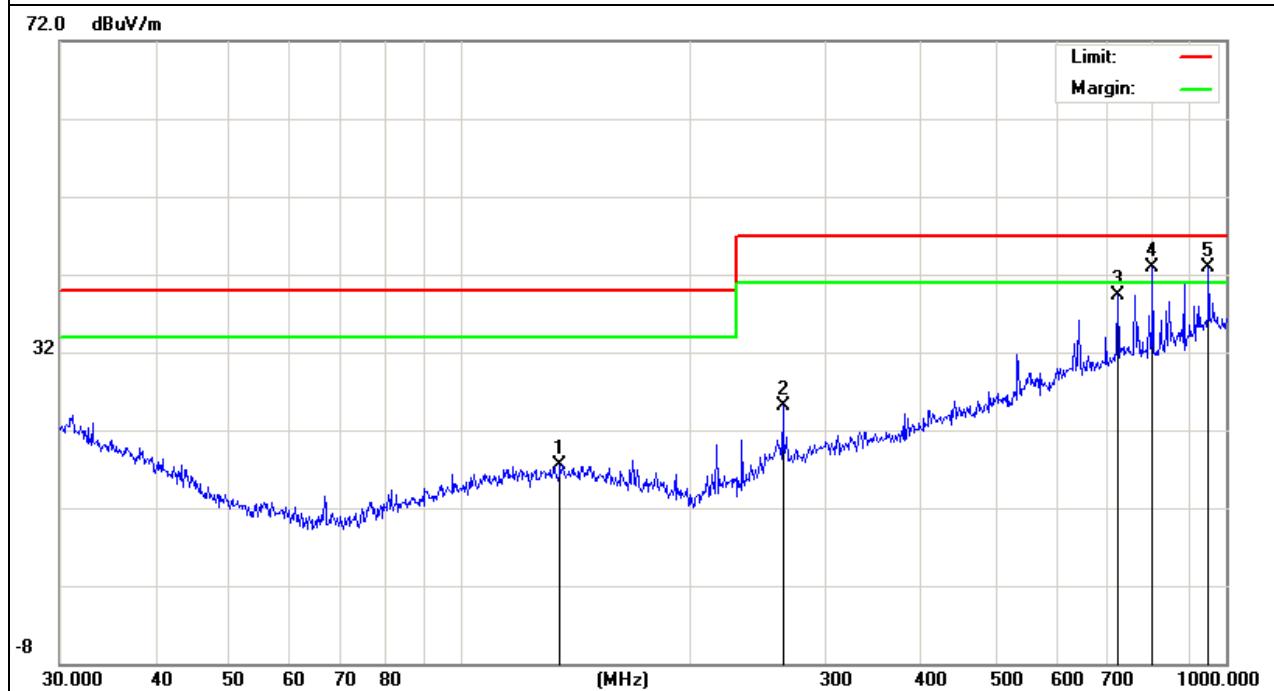


EUT :	USB Flash Drive	Model Name :	U100A
Temperature :	24 °C	Relative Humidity :	54%
Pressure :	1010 hPa	Test Date :	2013-03-11
Test Mode :	Data transmission	Polarization :	Vertical
Test Power :	DC 5V from PC 120V/60Hz		

Frequency (MHz)	Meter Reading (dB μ V)	Factor (dB)	Emission Level (dB μ V/m)	Limits (dB μ V/m)	Margin (dB)	Detector Type
135.0319	5.29	12.25	17.54	40	-22.46	QP
263.819	10.58	14.62	25.2	47	-21.8	QP
721.7259	13.66	25.59	39.25	47	-7.75	QP
801.7862	16.87	26.01	42.88	47	-4.12	QP
948.7609	13.15	29.75	42.9	47	-4.1	QP

Remark:

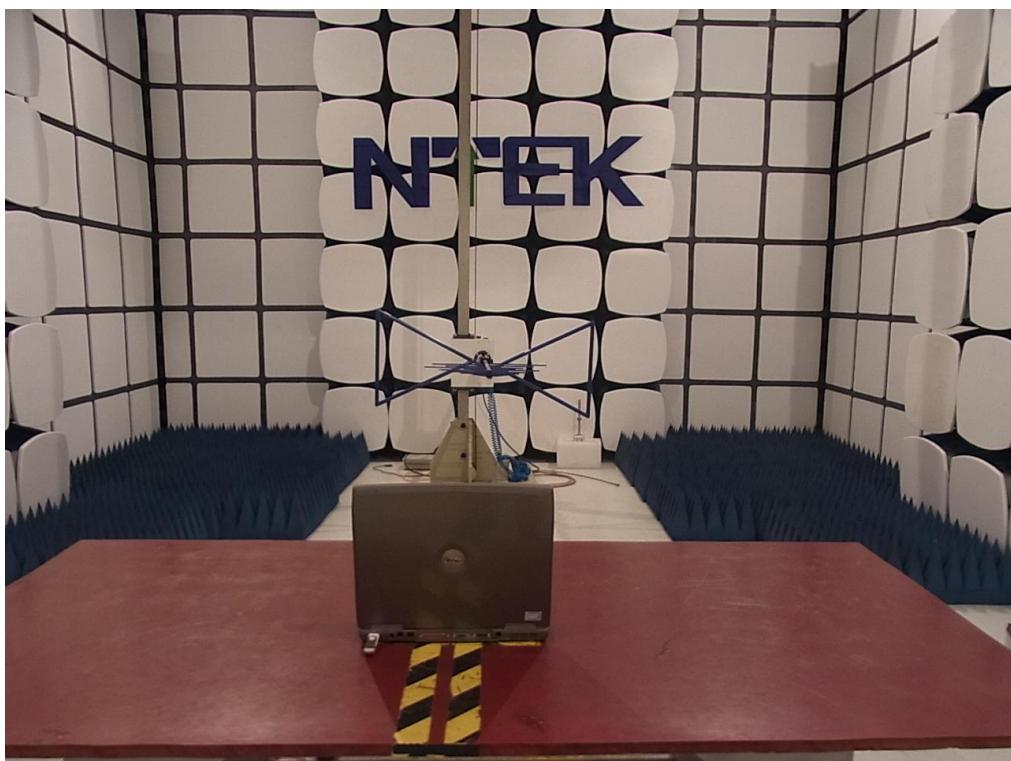
1. Factor = Antenna Factor + Cable Loss – Pre-amplifier.



3.2.6 TEST RESULTS(Above 1GHz)

EUT :	USB Flash Drive	Model Name :	U100A
Temperature :	24 °C	Relative Humidity :	54%
Pressure :	1010 hPa	Test Date :	N/A
Test Mode :	N/A		
Test Power :	N/A		

Note: No emission is detected above 1GHz

4. EUT TEST PHOTO**Radiated Measurement Photos**

Conducted Measurement Photos